Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/661,880	MISURA ET AL.	
Examiner	Art Unit	
Sharidan Carrillo	1746	

SEARCHED					
Class	Subclass	Date	Examiner		
15	77 88.2 88.3 106 9, 14	8/30/06	Bsc		
134	006				
	9, 15				
	18,32	1	$\mathcal{V}$		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consult w/ Frakie  Shis and Mark  Spisiel - Closo 15  Enst-us pat, 400,  jps, 1 BMT DB papels	8/33/26	1350		
FARS, EPD Comit w/ John				
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